

## Supplementary Information

### Stacked vanadium pentoxide-zinc oxide interface for optically-chargeable supercapacitor

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## 1 Digital image of the device



Fig. S1 Digital image of the fabricated symmetric supercapacitor using  $V_2O_5/ZnO/FTO$  electrodes.

## 2 Energy-dispersive X-ray spectroscopy (EDS) analysis of $V_2O_5/ZnO/FTO$

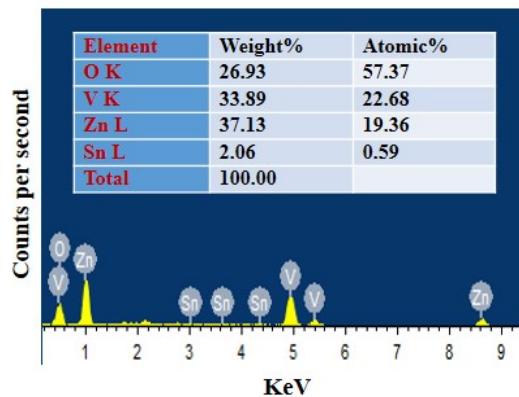
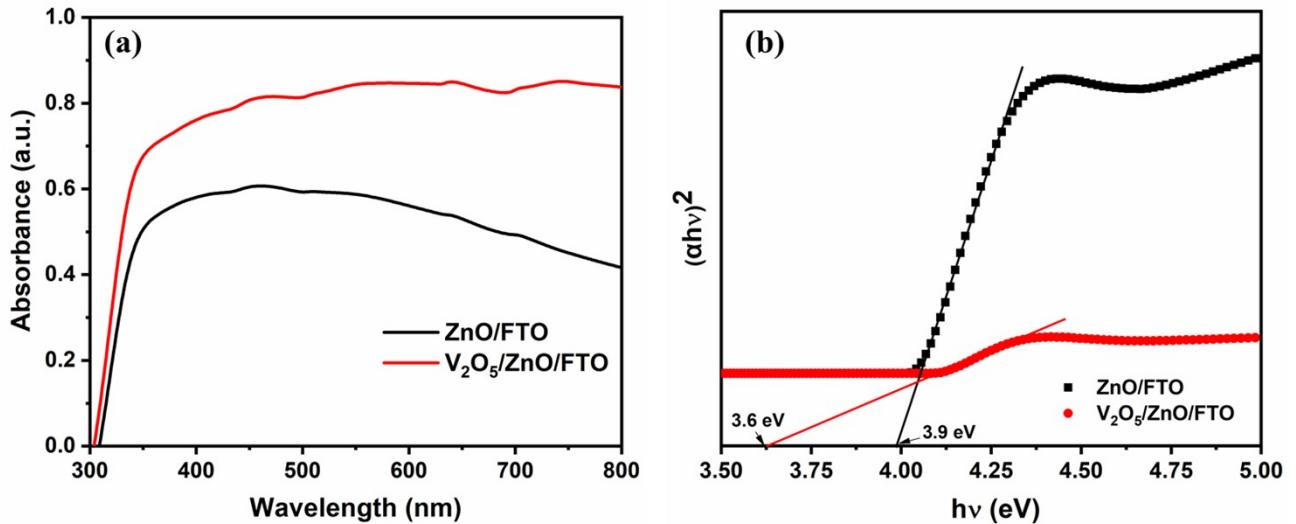


Fig. S2 EDS analysis of the  $V_2O_5/ZnO/FTO$  electrode showing atomic and weight percentages of different elements.

### 3 UV-Visible absorption spectroscopy



*Fig. S3(a)* UV-Visible spectra and (b) corresponding Tauc plots to calculate the band gap of ZnO/FTO and V<sub>2</sub>O<sub>5</sub>/ZnO/FTO heterostructure.

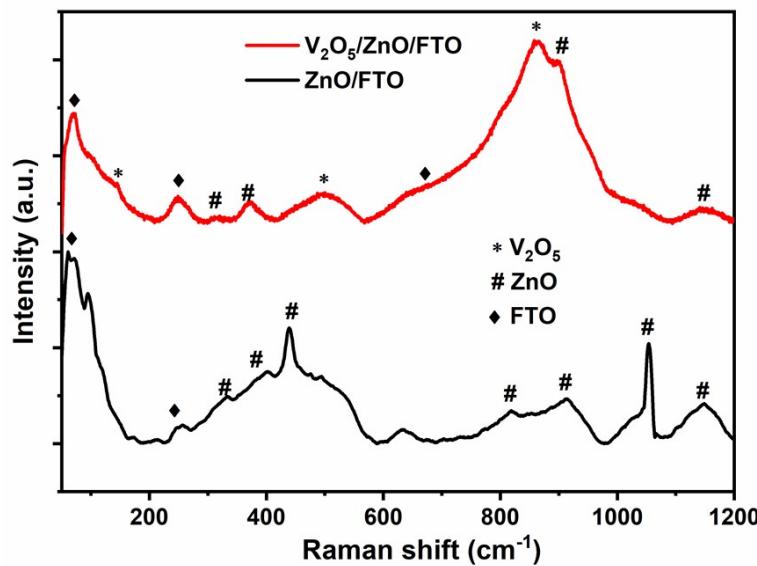
The UV-Visible spectroscopy of the synthesized heterostructure showed good optical absorbance in the UV (315-400 nm) and visible (400-780 nm) range of the electromagnetic spectrum (**Figure S3(a)**).<sup>1</sup> Interestingly, the heterostructured V<sub>2</sub>O<sub>5</sub>/ZnO showed a higher light absorption in the UV and visible range than ZnO, implying that the heterostructure is optically active and suitable for optoelectronic applications. The band gaps were evaluated by plotting  $(\alpha h\nu)^2$  versus photon energy ( $h\nu$ ) (Tauc plots, **Figure S3(b)**) according to Kubelka-Munk theory as:

$$\alpha h\nu = A(h\nu - E_g)^n \quad , \quad (1)$$

where  $\alpha$  is the absorption coefficient of the material,  $A$  is an energy-independent constant,  $h\nu$  is photon energy in eV,  $E_g$  is the material's bandgap, and  $n$  is a constant that depends upon the type of optical transition ( $n = 1/2$ , for direct transition). The calculated band gap values from the Tauc plots are 3.9 eV and 3.6 eV for ZnO/FTO and V<sub>2</sub>O<sub>5</sub>/ZnO/FTO, respectively. The slight reduction

in the bandgap of the heterostructure is advantageous for the electron transfer from the valence band to the conduction band under light irradiation.

#### 4 Raman spectroscopy analysis

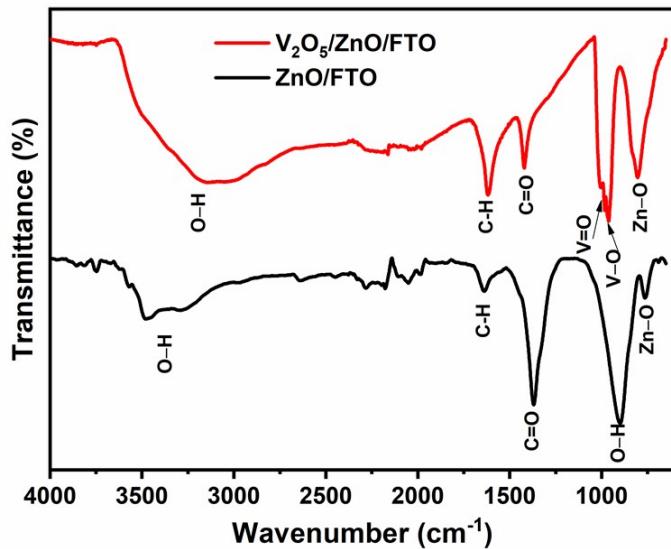


*Fig. S4 Raman spectra of  $\text{ZnO}/\text{FTO}$  and  $\text{V}_2\text{O}_5/\text{ZnO}/\text{FTO}$  heterostructure.*

The Raman spectrum of the synthesized heterostructure is compared to that of  $\text{ZnO}$  in the 50-1200  $\text{cm}^{-1}$  range (**Figure S4**). The peaks at 320, 371, and 437  $\text{cm}^{-1}$  belong to the  $E_2$  mode and the longitudinal mode vibrations of wurtzite  $\text{ZnO}$  nanorods.<sup>2</sup> Similarly, the peak at 1145  $\text{cm}^{-1}$  corresponds to the multi-phonon vibration of  $\text{ZnO}$ .<sup>3</sup> The  $\text{ZnO}$ 's Raman peak at 1055  $\text{cm}^{-1}$  corresponds to the rocking vibration of  $-\text{CH}_3$  from zinc acetate, while peaks at 820 and 916  $\text{cm}^{-1}$  correspond to the C–C stretching vibration of zinc acetate. The peak at 500  $\text{cm}^{-1}$  is due to triply coordinated oxygen ( $\text{V}_3\text{–O}$ ) stretching of the  $\text{V}_2\text{O}_5$  structure.<sup>2</sup> The low-frequency peak at 145  $\text{cm}^{-1}$  shows the layered structure of  $\text{V}_2\text{O}_5$ , which is useful in ion intercalation during electrochemical charge storage. The appearance of a vibrational peak at 850  $\text{cm}^{-1}$  confirms the composite formation

between the two metal oxides.<sup>4</sup> The rest of the peaks correspond to the FTO substrate, some of which are slightly shifted due to the heterostructure formation.

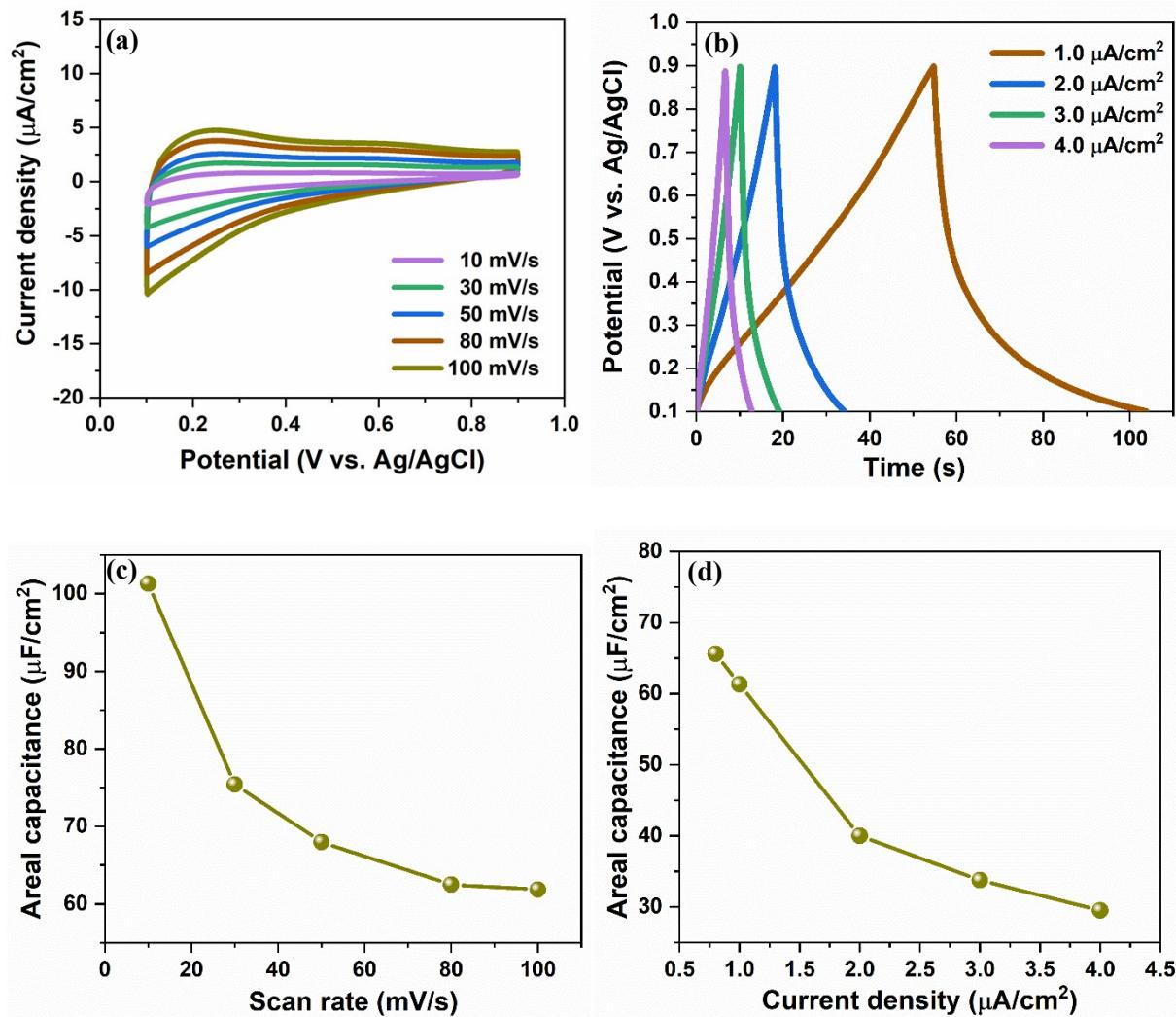
## 5 Fourier transform infrared spectroscopy analysis



*Fig. S5 FTIR spectra of ZnO/FTO and V<sub>2</sub>O<sub>5</sub>/ZnO/FTO heterostructure.*

The characteristic FTIR transmission spectra of ZnO and V<sub>2</sub>O<sub>5</sub>/ZnO heterostructure are shown in **Figure S5**. The peak at 750 cm<sup>-1</sup> corresponds to the Zn–O stretching mode that confirms the formation of ZnO,<sup>5</sup> while the heterostructure's spectrum shows the 960 and 1000 cm<sup>-1</sup> peaks that correspond to the symmetric stretching vibration of the V–O and V=O bond of vanadyl oxygen, respectively.<sup>6,7</sup> The 1366 cm<sup>-1</sup> peak corresponds to the C=O bond stretching vibration, and the 1622 cm<sup>-1</sup> peak to the C–H vibration resulting from the partial transformation of zinc acetate ions (Zn(CH<sub>3</sub>COO)<sub>2</sub>) into aldehyde during the synthesis.<sup>5,7</sup> The O–H stretching vibration is observed as a broad peak ranging from 3200 to 3600 cm<sup>-1</sup>.

**6      Electrochemical analysis of  $\text{V}_2\text{O}_5/\text{ZnO}/\text{FTO}$  heterostructure in a three-electrode system**



*Fig. S6 (a) CV and (b) GCD curve of  $\text{V}_2\text{O}_5/\text{ZnO}/\text{FTO}$  electrode measured in three-electrode system in the potential range of 0.1 to 0.9 V. (c) and (d) shows corresponding areal capacitance calculated from CV and GCD curve, respectively.*

7 Coulombic efficiency of the  $\text{V}_2\text{O}_5/\text{ZnO}/\text{FTO}$  heterostructure

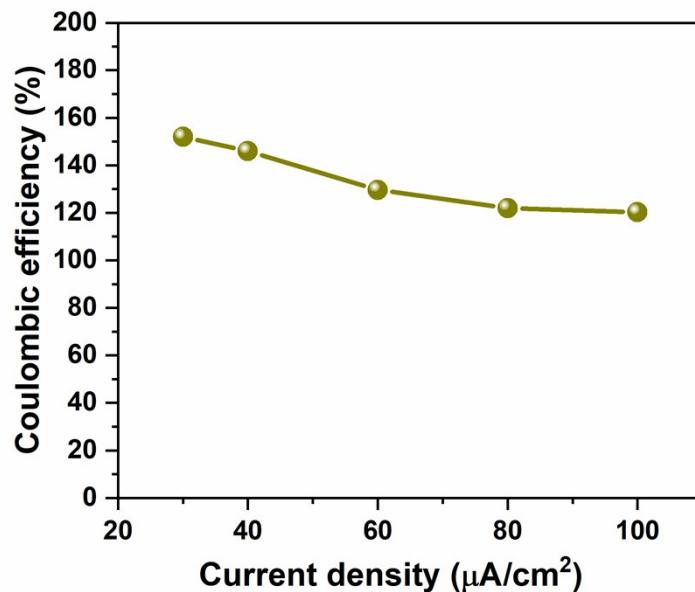


Fig. S7 Coulombic efficiency of  $\text{V}_2\text{O}_5/\text{ZnO}/\text{FTO}$  heterostructure at different current densities.

8 Areal capacitance of device

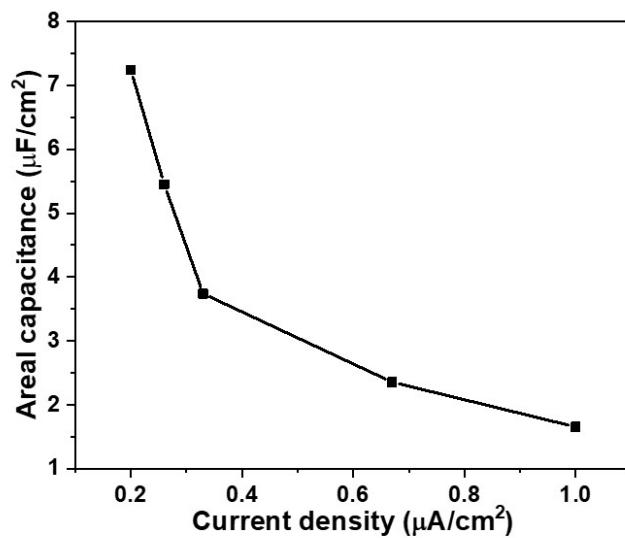
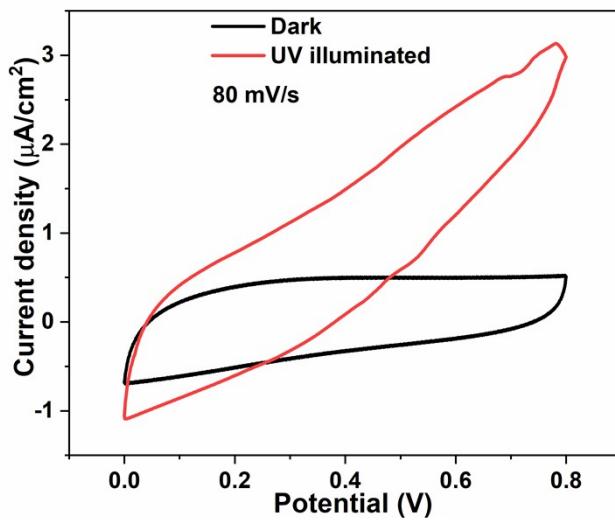


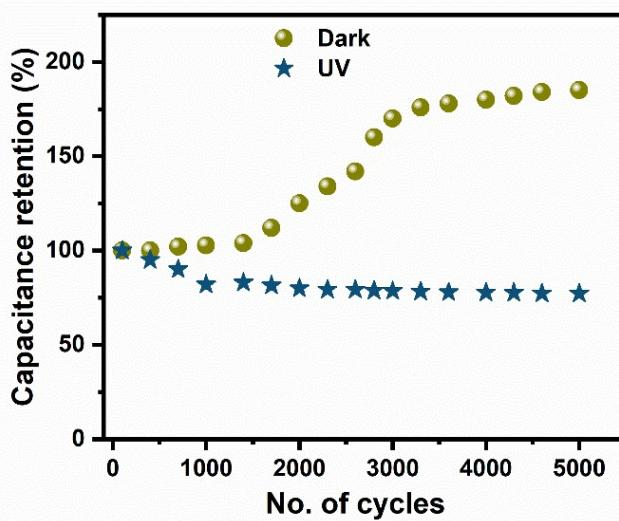
Fig. S8 Areal capacitance ( $C_A$ ) of the device at various current densities calculated from GCD curve using the integration method.

**9 Cyclic voltammetry comparison of the device under dark and UV-illuminated conditions**



*Fig. S9 CV curve of SSD at 80 mV/s scan rate under dark and UV illuminated conditions.*

**10 Capacitance retention**



*Fig. S10 Capacitance retention of the supercapacitor under dark and UV illuminated conditions.*

11 Effect of electrochemical cycles on the morphology and structure of  $\text{V}_2\text{O}_5/\text{ZnO}/\text{FTO}$  heterostructure

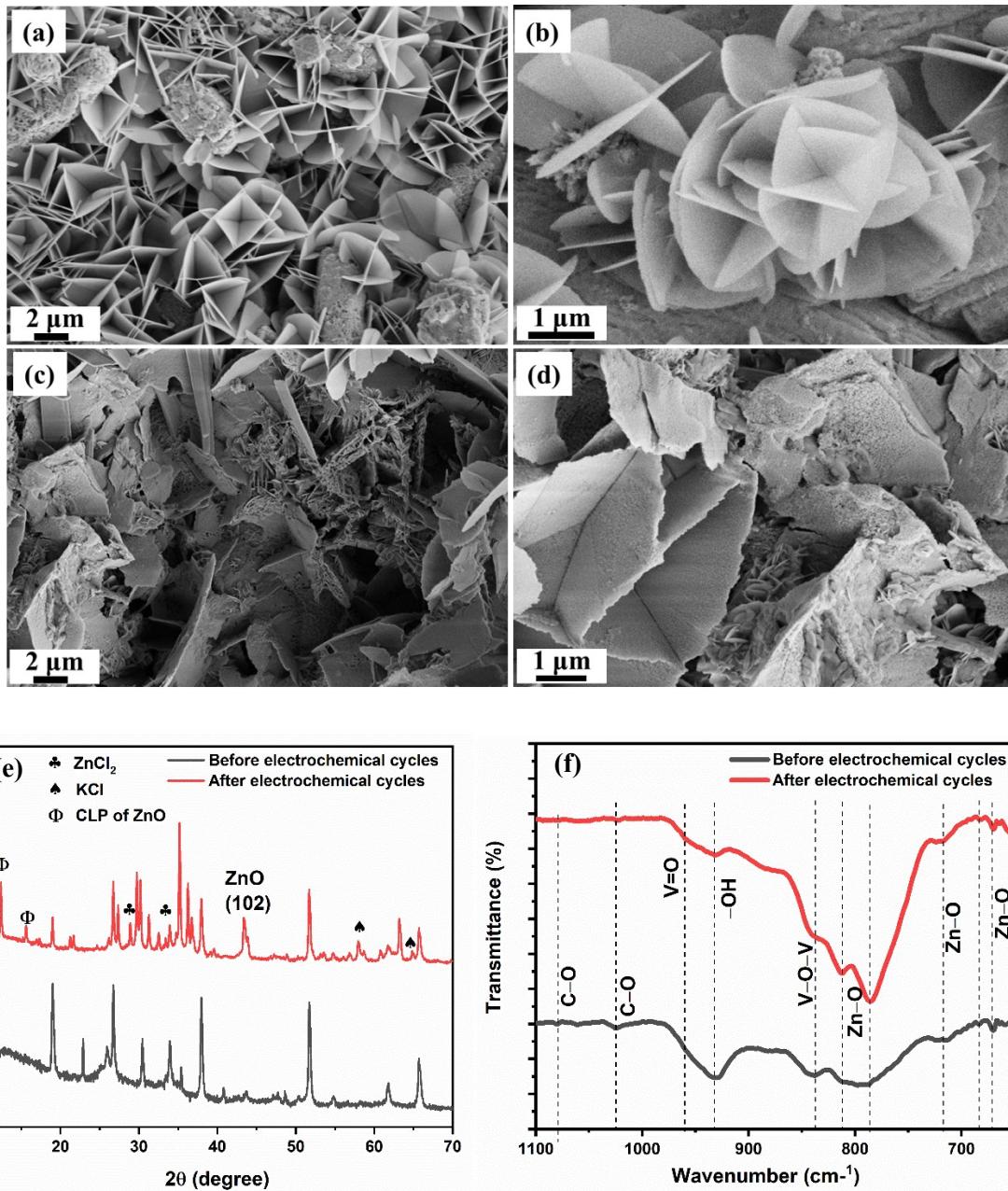


Fig. S11 (a) and (b) SEM images of  $\text{V}_2\text{O}_5/\text{ZnO}/\text{FTO}$  heterostructure before electrochemical cycles. (c) and (d) SEM images of  $\text{V}_2\text{O}_5/\text{ZnO}/\text{FTO}$  heterostructure after 3000 electrochemical cycles. (e) XRD and (f) FTIR analysis of  $\text{V}_2\text{O}_5/\text{ZnO}/\text{FTO}$  heterostructure before and after charge-discharge cycles in 1M KCl electrolyte. (CLP: chloride lamellar phase)

## 12 Comparison with other studies

Table S1: Comparison of V<sub>2</sub>O<sub>5</sub>/ZnO/FTO-based supercapacitor with similar studies conducted in past

S. No.	Material	Electrolyte	Capacitance	Ref.
1	Graphene thin films	PVA/H <sub>3</sub> PO <sub>4</sub>	12.4 µF/cm <sup>2</sup>	14
2	Graphene	PVA/H <sub>2</sub> SO <sub>4</sub>	5.33 µF/cm <sup>2</sup>	15
3	MAPbI <sub>3</sub> perovskite	PVA/KOH/Chlorobenzene	8.06 µF/cm <sup>2</sup>	16
4	graphene-graphene quantum dots chelate	PVA/H <sub>3</sub> PO <sub>4</sub>	9.09 µF/cm <sup>2</sup>	17
5	Silicon nanowires	NEt <sub>4</sub> BF <sub>4</sub> /polycarbonate	6.6 µF/cm <sup>2</sup>	18
6	ZnO nanowires over FTO glass	1M KCl	20 µF/cm <sup>2</sup>	19
7	Multilayer graphene	6M KOH	4 µF/cm <sup>2</sup>	20
8	<b>V<sub>2</sub>O<sub>5</sub>/ZnO/FTO</b>	<b>PVA/KCl</b>	<b>~15 µF/cm<sup>2</sup></b>	<b>This work</b>

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